Investigation on Physical and Electrical Properties of The SiO2-ZnO Nanocomposite at different Composition Mixings

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Article Info

ABSTRACT

Physical and electrical properties of The SiO2-ZnO mixing at different compositions were investigated. The experiment used simple mixing method at the sintering temperature 600°C. It was used the composition mixing ratio of SiO2:ZnO ie. 0:10; 7:3; 5:5; 3:7; and 10:0 (%Wt). Based on X-Ray Diffraction (XRD) results, it obtained that a new phase in each sample was not formed even though having different diffraction peak. The mixing ratio of SiO2: ZnO nanocomposite (7:3 %wt) had the biggest grain size (77.92 nm), the highest dielectric constant (3.00E+05) and the smallest conductivity (0.726549 (Ωm)-1). On the other side, the mixing ratio of SiO2: ZnO nanocomposite (5:5 %wt) had the smallest grain size (35.42nm), dielectric constant (3.00E+2) and the highest conductivity (25.36729 (Ωm)-1). It can be concluded that the difference of composition ratio offered the change on both physical and electrical properties of SiO2-ZnO nanocomposite.

Keyword:
Bioconversion
Biomass
Coffee Husk
Compost
Lettuce

1. INTRODUCTION

The development of semiconductor ceramic material technology recently has grown rapidly. It is indicated by the discovery of devices using semiconductor materials. In addition to its relatively easy manufacturing process, the semiconductor ceramic has some superior properties including corrosion resistance, high heat capacity, and high melting point. It also can act as an insulator, conductor, even superconductor. The thin layer technology has undergone many developments both in terms of manufacturing and materials used. In the thin film technology, polycrystalline metal-oxide materials have been widely applied in which defect properties of a material has been utilized.

One of metal oxide materials is zinc oxide (ZnO). ZnO has unique dual properties both as semiconductor and also piezoelectric. A crystalline ZnO has a hexagonal wurtzite structure with lattice parameters a = 0.3296 and c = 0.520 65 nm. ZnO also has a direct wide band-gap (3.37 eV) with the high exciton binding energy (60 Me)[1]. Due to its properties, ZnO proposes as a potential candidate for various applications such as a chemical sensor, photoluminescence, solar cell, photocatalyst, light emitting device [2]–[6]. Recently, ZnO based nanocomposite materials have dragged a special attention to exploring its interaction characteristics with ultraviolet (UV), visible emissions, white light [7], for example, SiO2-ZnO nanocomposite. SiO2-ZnO nanocomposite was grown by using different techniques such as sputtering [7], sol-gel[2], spray-drying process [8], sonochemical methods [9], photovoltaic [10].

Every method which is applied to grow ZnO based composite shall produce different results. Therefore, the aims of this paper are to investigate the physical and electrical properties of SiO2-ZnO nanocomposite using the other methods mentioned above, simple mixing.
2. RESEARCH METHOD

The experiment was begun by preparing pure SiO2 and ZnO powder. These materials were weighed using a digital balance Pioneer, Ohaus Corporation with the mixing ratio of SiO2:ZnO i.e. 0:10, 3:7, 5:5, 7:3 and 10:0 (% wt). Furthermore, these SiO2:ZnO mixings were mixed with alcohol 96% using a magnetic stirrer with a constant speed of 300 rpm at temperature 80°C. After samples were uniformly mixed, it was dried at room temperature until the perfect dried mixing powder reached. Next, it was heated to a calcination temperature of 600 °C for 1 hour. The samples then analyzed by means of X-Ray Diffraction (XRD) test.

To investigate electrical properties of the samples, it was made pellets with diameter 1.025 cm under pressure 8 ton by means of machine press type Carver. The pellets were then heated at a temperature of sintering 1100 °C for 1 hour using a Furnace type Brother XD-1700M. Both the surface of the Pellet was coated with Silver silver Electrode and tested using LCR Meter Fluke Type PM 6306.

3. RESULTS AND DISCUSSION

3.1. X-Ray Diffraction

The XRD test used CuKα as sourced rays with a wavelength of 1.54098 Å. It obtained its test results for each sample as in figure 1.

Based on Fig. 1, SiO2 has an amorphous structure and ZnO has a crystal structure. It can be noticed that the mixing process formed a nanocomposite with the absence of a new phase. The peak points of SiO2 seems to appear on the mixing of 7SiO2:5ZnO and 5SiO2:5ZnO. The emergence of peaks at these mixtures allegedly caused by the big amount of SiO2 added. Low-temperature calcination considered as one of the factors the small peak of SiO2 or no peak in the sample in which interaction between SiO2 and ZnO was weak.

Search Match analysis presented that after the match between the standard data with the XRD graph of SiO2, cristobalite and quartz appeared. Furthermore, the XRD patterns indicate the ZnO’s highest peak at an angle θ 2:31.80, 34.45, 36.28, 47.56 and 56.61 which can be categorized in wurtzite crystal structure (hexagonal phase).

On the composition mixing ratio of 7SiO2:3ZnO and 5SiO2:5ZnO it is clear that the peaks appear about 21 ° and 24 °. Moreover, the composition mixing ratio of 5SiO2:5ZnO on 2θ is about 21 °, 24°, and 26°.

Using Fig. 1, the grain size of samples can be calculated using The Scherrer Formula by measuring the width by half the height of the highest XRD band.

\[ D = \frac{k \lambda}{\beta \cos \theta} \]  

(1)
where \( D \) is the grain size, \( k \) is the shape factor of crystallite, \( \lambda \) is the XRD wavelength, \( \beta \) the line broadening at half the maximum intensity (FWHM), and \( \cos \theta \) is the Bragg angle. The grain sizes of the SiO\(_2\) : ZnO nanocomposite can be calculated using Eq. 1 and are written in Table 1.

Table 1. The grain size of samples

<table>
<thead>
<tr>
<th>Sample</th>
<th>( D_{\text{mean}} ) (nm)</th>
</tr>
</thead>
<tbody>
<tr>
<td>0 SiO(_2) : 10 ZnO</td>
<td>6,79</td>
</tr>
<tr>
<td>3 SiO(_2) : 7 ZnO</td>
<td>65,04</td>
</tr>
<tr>
<td>5 SiO(_2) : 5 ZnO</td>
<td>35,42</td>
</tr>
<tr>
<td>7 SiO(_2) : 3 ZnO</td>
<td>77,92</td>
</tr>
</tbody>
</table>

It is clear that the composition mixing of 7SiO\(_2\) : 3 ZnO has the biggest grain size. On the contrary, 5 SiO\(_2\) : 5 ZnO has the smallest grain size.

### 3.2. RCL meter analysis

Measurement of electric parameters yielded the resistance value (R), Dissipation (D), Capacitance (C) and the impedance (Z) under the influence of frequency 1000Hz-1MHz and voltage 1 Volt.

The relative permittivity or dielectric constant is the electrostatic flux density in a material when an electric potential is applied. Dielectric constant also indicates the ability of a material to dampen the intensity of electric field which passes through the material. This quantity is commonly expressed by \( \varepsilon_r \). Permittivity is strongly influenced by the amount of charge stored in a dielectric material. If a capacitor is filled with a dielectric material, then its properties can be analyzed using relative permittivity. The dielectric constant of the SiO\(_2\)-ZnO nanocomposite can be calculated using the following equation:

\[
\varepsilon_r = \frac{C \cdot d}{\varepsilon_0 \cdot A} \tag{2}
\]

where \( C \) is capacitance (F), \( d \) is the thickness of the sample (m), \( A \) is area \((8,26 \times 10^{-7} \text{ m}^2)\), \( \varepsilon_0 \) is permittivity in a vacuum \((8,85 \times 10^{-12} \text{ F/m})\). Real permittivity can be calculated using

\[
\varepsilon_r' = \frac{\varepsilon_r^2}{\varepsilon_0 \cdot A}, \tag{3}
\]

and Imaginary permittivity:

\[
\varepsilon_r'' = \varepsilon_r' \cdot D \tag{4}
\]

with \( D \) is dissipation factor which also indicates the power lost in a capacitor.

In Fig. 2, permittivity has a downward trend along with the increasing frequency. The increasing frequency directly effects on the electrical field oscillations in which oscillates faster. It makes some charges which are involved in redistribution process cannot keep the alteration of electric field direction up. It also can cause...
polarization reduction. The highest permittivity is the 7SiO2:7ZnO nanocomposite (3.00E+05) and the smallest is the 5SiO2:5ZnO nanocomposite (3.00E+02).

Dielectric constant has the real and the imaginary part. The real permittivity indicates the ability of materials to store the charge or electrical energy. When the real part is positive, the phase shift is positive and the material has an intrinsically capacitative optical response. On the contrary, the real part is negative, the phase shift between electric and magnetic fields is negative and the material has an inductive optical response. The phase shift of samples under the various frequencies influence is given in Fig. 3

![Figure 3. The influence of frequency toward real permittivity of the samples](image)

In Fig. 3, it figures out the positive phase shift of the samples. It can be said that all samples have an intrinsically capacitative optical response. The higher frequency indicates the smaller capacitive response. It is clear that the 3SiO2:7ZnO nanocomposite has the highest real permittivity 2.5E+09 and the smallest is the 5SiO2:5ZnO (2.4 x 10^6).

Furthermore, the imaginary part represents the energy losses as a consequence of polarization mechanism and responsible for the effective resistance. The imaginary permittivity of the samples which vary in different frequencies described in Fig. 4 as follows

![Figure 4. The relation between frequency toward imaginary permittivity](image)

The imaginary permittivity also has a downward trend along with the increasing frequency. The highest permittivity is the 7SiO2:3ZnO nanocomposite (3.3E+10) and the smallest is the 3SiO2:7ZnO nanocomposite. The real permittivity which is plotted against the imaginary permittivity produces a semi-circle radius which is well-known as a cole-cole plot. Theoretically, a cole-cole plot indicates the relaxation times of a dielectric material. If a cole-cole plot has a perfect semi-circle shape, it is found that a dielectric material has a short relaxation time. This mechanism indicates a single polarization occurred in a dielectric. The plot between the real permittivity and imaginary permittivity is figured as in Fig. 5
Figure 5. The relation between real permittivity and imaginary permittivity of samples

Based Fig. 5, the 7SiO$_2$:3ZnO nanocomposite mixing has much better the semi-circle shape than others. This indicates that the sample requires a longer relaxation time in which describing dipoles reorientation into the initial state. For other samples, the 5SiO$_2$:5ZnO and 3SiO$_2$:7ZnO has also good semi-circle shapes, but the 3SiO$_2$:7ZnO provides the shortest relaxation time by comparing its imaginary permittivity.

Electrical conductivity is an intrinsic property of the material to conduct electrical current flow. Using the electrical conductivity value, it can be determined a material categorized as an insulator, conductor or semiconductor. The electrical conductivity is calculated using the equation as follows:

$$\sigma = \frac{1}{\rho} = \frac{l}{RA}$$  (5)

where $\sigma$ is the electrical conductivity (Ωm)$^{-1}$, $\rho$ is the electrical resistivity (Ωm), $l$ is the distance between the two measurement points, $R$ is resistance (Ω), $A$ is the capacitor area (m$^2$).

Using Eq. (5), the electrical conductivity of samples can be determined. It is figured out in the following graph:

Figure 6. The relation between the composition ratio of SiO$_2$: ZnO toward electrical conductivity

It appears in Fig. 6 that the 5SiO$_2$:5ZnO has the highest the electrical conductivity (25.36729 (Ωm)$^{-1}$) and the lowest one is the 7SiO$_2$: 3ZnO which is the amount of 0.726549 (Ωm)$^{-1}$. Comparing to Table 1, it can be noticed that there is a relation between the grain size and the electrical conductivity. If the mixing sample has a smaller grain size, it possesses the higher electrical conductivity but the smaller dielectric constant. This phenomenon is related to the fraction of the number atoms occupying the surface of particles per unit volume.
CONCLUSION

It can be concluded that the variations of the composition mixing alter the physical properties and electrical properties of the SiO$_2$: ZnO nanocomposite material. There is a new phase formed in each sample. It obtained the 7SiO$_2$: 3ZnO amount of has the highest grain size (77.92 nm), the highest dielectric constant, the highest imaginary permittivity and the longer relaxation time. But it has the smallest conductivity ($0.726549 \, (\Omega m)^{-1}$). Moreover, the 5SiO$_2$: 5ZnO has the smallest grain size (35.42 nm) and the highest conductivity (25.36729 ($\Omega m)^{-1}$). The 3SiO$_2$: 7ZnO has the lowest dielectric constant and the lowest imaginary permittivity.

REFERENCES